

FEATURES 4Mb Serial SPI MRAM

- No write delays
- Unlimited write endurance
- Data retention greater than 20 years
- Automatic data protection on power loss
- Fast, simple SPI interface with up to 40 MHz clock rate
- 3.0 to 3.6 Volt power supply range
- · Low current sleep mode
- Industrial temperatures
- Available in 8-pin DFN or 8-pin DFN Small Flag RoHS-compliant packages.
- Direct replacement for serial EEPROM, Flash, FeRAM



INTRODUCTION

The **MR25H40** is a 4,194,304-bit magnetoresistive random access memory (MRAM) device organized as 524,288 words of 8 bits. The **MR25H40** offers serial EEPROM and serial Flash compatible read/write timing with no write delays and unlimited read/write endurance.



Unlike other serial memories, both reads and writes can occur randomly in memory with no delay between writes. The **MR25H40** is the ideal memory solution for applications that must store and retrieve data and programs quickly using a small number of I/O pins.

The **MR25H40** is available in either a 5 mm x 6 mm 8-pin DFN package or a 5 mm x 6 mm 8-pin DFN Small Flag package. Both are compatible with serial EEPROM, Flash, and FeRAM products.

The **MR25H40** provides highly reliable data storage over a wide range of temperatures. The product is offered with industrial (-40 $^{\circ}$ to +85 $^{\circ}$ C) and AEC-Q100 Grade 1 (-40 $^{\circ}$ C to +125 $^{\circ}$ C) operating temperature range options.

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1. DEVICE PIN ASSIGNMENT

Overview

The MR25H40 is a serial MRAM with memory array logically organized as 512Kx8 using the four pin interface of chip select (CS), serial input (SI), serial output (SO) and serial clock (SCK) of the serial peripheral interface (SPI) bus. Serial MRAM implements a subset of commands common to today's SPI EEPROM and Flash components allowing MRAM to replace these components in the same socket and interoperate on a shared SPI bus. Serial MRAM offers superior write speed, unlimited endurance, low standby & operating power, and more reliable data retention compared to available serial memory alternatives.

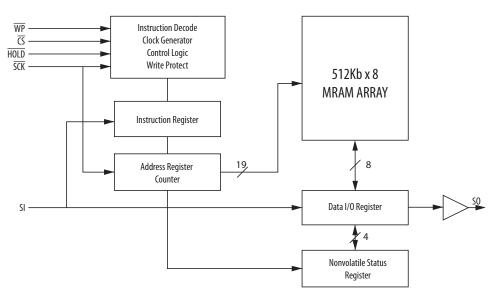


Figure 1.1 Block Diagram

System Configuration

Single or multiple devices can be connected to the bus as show in Figure 1.2. Pins SCK, SO and SI are common among devices. Each device requires $\overline{\text{CS}}$ and $\overline{\text{HOLD}}$ pins to be driven seperately.

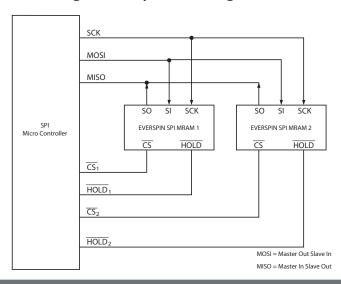
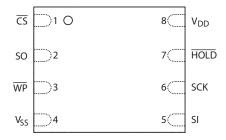


Figure 1.2 System Configuration

Figure 1.2 Pin Diagrams (Top View)



8-Pin DFN or 8-Pin DFN Small Flag

Table 1.1 Pin Functions

Signal Name	Pin	I/O	Function	Description
<u>cs</u>	1	Input	Chip Select	An active low chip select for the serial MRAM. When chip select is high, the memory is powered down to minimize standby power, inputs are ignored and the serial output pin is Hi-Z. Multiple serial memories can share a common set of data pins by using a unique chip select for each memory.
SO	2	Output	Serial Output	The data output pin is driven during a read operation and remains Hi-Z at all other times. SO is Hi-Z when HOLD is low. Data transitions on the data output occur on the falling edge of SCK.
WP	3	Input	Write Protect	A low on the write protect input prevents write operations to the Status Register.
V _{ss}	4	Supply	Ground	Power supply ground pin.
SI	5	Input	Serial Input	All data is input to the device through this pin. This pin is sampled on the rising edge of SCK and ignored at other times. SI can be tied to SO to create a single bidirectional data bus if desired.
SCK	6	Input	Serial Clock	Synchronizes the operation of the MRAM. The clock can operate up to 40 MHz to shift commands, address, and data into the memory. Inputs are captured on the rising edge of clock. Data outputs from the MRAM occur on the falling edge of clock. The serial MRAM supports both SPI Mode 0 (CPOL=0, CPHA=0) and Mode 3 (CPOL=1, CPHA=1). In Mode 0, the clock is normally low. In Mode 3, the clock is normally high. Memory operation is static so the clock can be stopped at any time.
HOLD	7	Input	Hold	A low on the Hold pin interrupts a memory operation for another task. When HOLD is low, the current operation is suspended. The device will ignore transitions on the CS and SCK when HOLD is low. All transitions of HOLD must occur while CS is low.
V _{DD}	8	Supply	Power Supply	Power supply voltage from +3.0 to +3.6 volts.

2. SPI COMMUNICATIONS PROTOCOL

MR25H40 can be operated in either SPI Mode 0 (CPOL=0, CPHA =0) or SPI Mode 3 (CPOL=1, CPHA=1). For both modes, inputs are captured on the rising edge of the clock and data outputs occur on the falling edge of the clock. When not conveying data, SCK remains low for Mode 0; while in Mode 3, SCK is high. The memory determines the mode of operation (Mode 0 or Mode 3) based upon the state of the SCK when $\overline{\text{CS}}$ falls.

All memory transactions start when CS is brought low to the memory. The first byte is a command code. Depending upon the command, subsequent bytes of address are input. Data is either input or output. There is only one command performed per CS active period. CS must go inactive before another command can be accepted. To ensure proper part operation according to specifications, it is necessary to terminate each access by raising CS at the end of a byte (a multiple of 8 clock cycles from CS dropping) to avoid partial or aborted accesses.

Instruction **Description Binary Code Hex Code Address Bytes Data Bytes WREN** Write Enable 0000 0110 0 06h **WRDI** 0 Write Disable 0000 0100 04h 0 **RDSR** Read Status Register 0000 0101 05h 0 1 **WRSR** Write Status Register 0000 0001 01h 0 1 3 **RFAD** Read Data Bytes 0000 0011 03h 1 to ∞ **WRITE** 02h 3 Write Data Bytes 0000 0010 1 to ∞ **SLEEP** Enter Sleep Mode B9h 0 0 1011 1001 0 **WAKE** Exit Sleep Mode 1010 1011 **ABh** 0

Table 2.1 Command Codes

Status Register

The status register consists of the 8 bits listed in table 2.2. As seen in table 2.3, the Status Register Write Disable bit (SRWD) is used in conjunction with bit 1 (WEL) and the Write Protection pin (WP) to provide hardware memory block protection. Bits BPO and BP1 define the memory block arrays that are protected as described in table 2.4. The fast writing speed of MR25H40 does not require write status bits. The state of bits 6,5,4, and 0 can be user modified and do not affect memory operation. All bits in the status register are pre-set from the factory in the "0" state.

Table 2.2 Status Register Bit Assignments

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
SRWD	Don't Care	Don't Care	Don't Care	BP1	BP0	WEL	Don't Care

Table 2.3 Memory Protection Modes

WEL	SRWD	WP	Protected Blocks	Unprotected Blocks	Status Register
0	Χ	Х	Protected	Protected	Protected
1	0	Х	Protected	Writable	Writable
1	1	Low	Protected	Writable	Protected
1	1	High	Protected	Writable	Writable

Table 2.4 Block Memory Write Protection

Status Register		Memory Contents		
BP1	BP0	Protected Area	Unprotected Area	
0	0	None	All Memory	
0	1	Upper Quarter	Lower Three-Quarters	
1	0	Upper Half	Lower Half	
1	1	All	None	

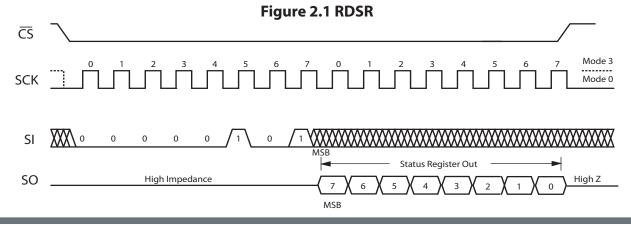
Block Protection

The memory enters hardware block protection when the WP input is low and the Status Register Write Disable (SRWD) bit is set to 0. The memory leaves hardware block protection only when the WP pin goes high. While WP is low, the write protection blocks for the memory are determined by the status register bits BPO and BP1 and cannot be modified without taking the WP signal high again.

If the WP signal is high (independent of the status of SRWD bit), the memory is in software protection mode. This means that block write protection is controlled solely by the status register BP0 and BP1 block write protect bits and this information can be modified using the WRSR command.

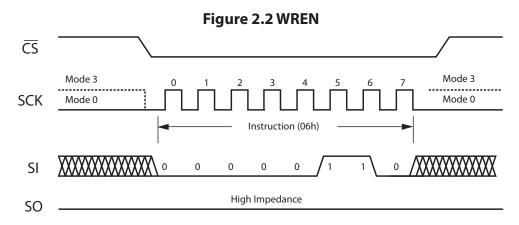
Read Status Register (RDSR)

The Read Status Register (RDSR) command allows the Status Register to be read. The Status Register can be read at any time to check the status of write enable latch bit, status register write protect bit, and block write protect bits. For MR25H40, the write in progress bit (bit 0) is not written by the memory because there is no write delay. The RDSR command is entered by driving \overline{CS} low, sending the command code, and then driving \overline{CS} high.



Write Enable (WREN)

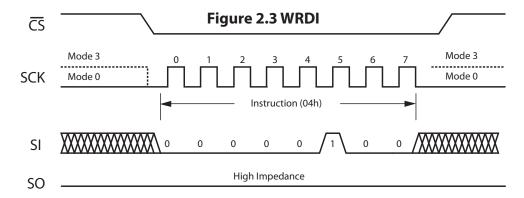
The Write Enable (WREN) command sets the Write Enable Latch (WEL) bit in the status register (bit 1). The Write Enable Latch must be set <u>prior</u> to writing either bit in the status register or the <u>memory</u>. The WREN command is entered by driving CS low, sending the command code, and then driving CS high.



Write Disable (WRDI)

The Write Disable (WRDI) command resets the Write Enable Latch (WEL) bit in the status register (bit 7). This prevents writes to status register or memory. The WRDI command is entered by driving CS low, sending the command code, and then driving CS high.

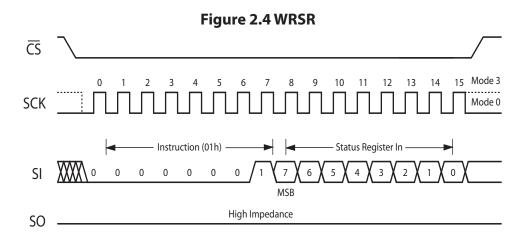
The Write Enable Latch (WEL) is reset on power-up or when the WRDI command is completed.



Write Status Register (WRSR)

The Write Status Register (WRSR) command allows new values to be written to the Status Register. The WRSR command is not executed unless the Write Enable Latch (WEL) has been set to 1 by executing a WREN command while pin WP and bit SRWD correspond to values that make the status register writable as seen in table 2.3. Status Register bits are non-volatile with the exception of the WEL which is reset to 0 upon power cycling.

The WRSR command is entered by driving \overline{CS} low, sending the command code and status register write data byte, and then driving \overline{CS} high.



Read Data Bytes (READ)

The Read Data Bytes (READ) command allows data bytes to be read starting at an address specified by the 24-bit address. Only address bits 0-18 are decoded by the memory. The data bytes are read out sequentially from memory until the read operation is terminated by bringing \overline{CS} high The entire memory can be read in a single command. The address counter will roll over to 0000h when the address reaches the top of memory.

The READ command is entered by driving \overline{CS} low and sending the command code. The memory drives the read data bytes on the SO pin. Reads continue as long as the memory is clocked. The command is terminated by bringing \overline{CS} high.

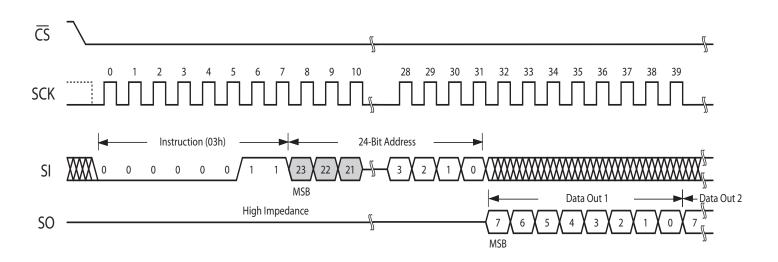


Figure 2.5 READ

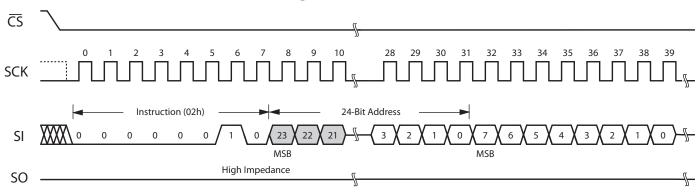
Write Data Bytes (WRITE)

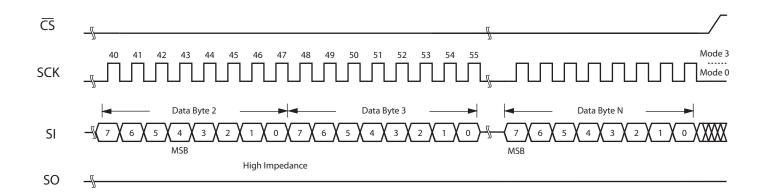
The Write Data Bytes (WRITE) command allows data bytes to be written starting at an address specified by the 24-bit address. Only address bits 0-18 are decoded by the memory. The data bytes are written sequentially in memory until the write operation is terminated by bringing \overline{CS} high. The entire memory can be written in a single command. The address counter will roll over to 0000h when the address reaches the top of memory.

Unlike EEPROM or Flash Memory, MRAM can write data bytes continuously at its maximum rated clock speed without write delays or data polling. Back to back WRITE commands to any random location in memory can be executed without write delay. MRAM is a random access memory rather than a page, sector, or block organized memory so it is ideal for both program and data storage.

The WRITE command is entered by driving \overline{CS} low, sending the command code, and then sequential write data bytes. Writes continue as long as the memory is clocked. The command is terminated by bringing \overline{CS} high.







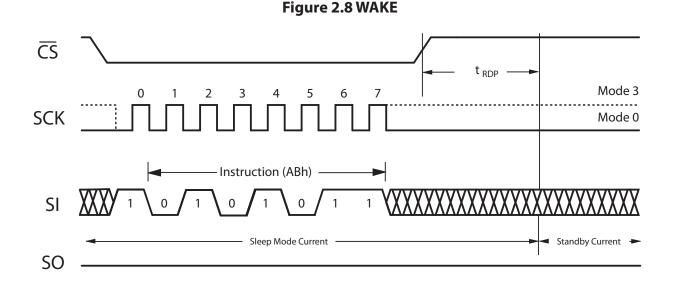
Enter Sleep Mode (SLEEP)

The Enter Sleep Mode (SLEEP) command turns off all MRAM power regulators in order to reduce the overall chip standby power to 15 μ A <u>typical</u>. The SLEEP command is entered by driving \overline{CS} low, sending the command code, and then driving \overline{CS} high. The standby current is achieved after time, t_{DP} . If power is removed when the part is in sleep mode, upon power restoration, the part enters normal standby. The only valid command following SLEEP mode entry is a WAKE command.

Figure 2.7 SLEEP

Exit Sleep Mode (WAKE)

The Exit Sleep Mode (WAKE) command turns on internal MRAM power regulators to allow normal operation. The WAKE command is entered by driving \overline{CS} low, sending the command code, and then driving \overline{CS} high. The memory returns to standby mode after t_{RDP} . The \overline{CS} pin must remain high until the t_{RDP} period is over. WAKE must be executed after sleep mode entry and prior to any other command.



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3. ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings

This device contains circuitry to protect the inputs against damage caused by high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage greater than maximum rated voltages to these high-impedance (Hi-Z) circuits.

The device also contains protection against external magnetic fields. Precautions should be taken to avoid application of any magnetic field more intense than the field intensity specified in the maximum ratings.

Parameter	Symbol	Value	Unit
Supply voltage ²	V _{DD}	-0.5 to 4.0	V
Voltage on any pin ²	V _{IN}	$-0.5 \text{ to V}_{DD} + 0.5$	V
Output current per pin	I _{OUT}	±20	mA
Package power dissipation ³	P_{D}	0.600	W
Temperature under bias MR25H40C (Industrial)	T _{BIAS}	-45 to 95	°C
Temperature under bias MR25H40M (AEC-Q100 Grade 1)	T _{BIAS}	-45 to 135	°C
Storage Temperature	T _{stg}	-55 to 150	°C
Lead temperature during solder (3 minute max)	T _{Lead}	260	°C
Maximum magnetic field during write	H _{max_write}	12,000	A/m
Maximum magnetic field during read or standby	H _{max_read}	12,000	A/m

¹ Permanent device damage may occur if absolute maximum ratings are exceeded. Functional operation should be restricted to recommended operating conditions. Exposure to excessive voltages or magnetic fields could affect device reliability.

² All voltages are referenced to V_{SS} . The DC value of V_{IN} must not exceed actual applied V_{DD} by more than 0.5V. The AC value of V_{IN} must not exceed applied V_{DD} by more than 2V for 10ns with I_{IN} limited to less than 20mA.

³ Power dissipation capability depends on package characteristics and use environment.

Table 3.2 Operating Conditions

Parameter	Symbol	Min	Typical	Max	Unit
Power supply voltage	V _{DD}	3.0		3.6	V
Input high voltage	V _{IH}	2.2	-	V _{DD} + 0.3	V
Input low voltage	V _{IL}	-0.5	-	0.8	V
Temperature under bias MR25H40C (Industrial)	T _A	-40	-	85	°C
Temperature under bias MR25H40M (AEC-Q100 Grade 1) ¹	T _A	-40	-	125	°C

¹AEC-Q100 Grade 1 temperature profile assumes 10 percent duty cycle at maximum temperature (2 years out of 20-year life.)

Table 3.3 DC Characteristics

Parameter	Symbol	Min	Typical	Max	Unit
Input leakage current	I _u	-	-	±1	μΑ
Output leakage current	I _{LO}	-	-	±1	μΑ
Output low voltage $(I_{OL} = +4 \text{ mA})$ $(I_{OL} = +100 \mu\text{A})$	V _{OL}	-	-	0.4 V _{SS} + 0.2v	V
Output high voltage $(I_{OH} = -4 \text{ mA})$ $(I_{OH} = -100 \mu\text{A})$	V _{OH}	2.4 V _{DD} - 0.2	-	-	V

Table 3.4 Power Supply Characteristics

Parameter	Symbol	Typical	Max	Unit
Active Read Current (@ 1 MHz)	l _{DDR}	5.0	11	mA
Active Read Current (@ 40 MHz)	I _{DDR}	12	17	mA
Active Write Current (@ 1 MHz)	I _{DDW}	9.0	25	mA
Active Write Current (@ 40 MHz)	I _{DDW}	28	42	mA
AC Standby Current (CS High)	I _{SB1}	250	400	μΑ
CMOS Standby Current (CS High)	I _{SB2}	90	180	μΑ
Standby Sleep Mode Current (CS High)	l _{zz}	15	40	μΑ

4. TIMING SPECIFICATIONS

Table 4.1 Capacitance¹

Parameter	Symbol	Typical	Max	Unit
Control input capacitance	C _{In}	-	6	pF
Input/Output capacitance	C _{I/O}	-	8	pF

 $^{^{1}~}f=1.0~\mathrm{MHz},\,\mathrm{dV}=3.0~\mathrm{V},\mathrm{T_{A}}=25~\mathrm{^{\circ}C},$ periodically sampled rather than 100% tested.

Table 4.2 AC Measurement Conditions

Parameter	Value	Unit	
Logic input timing measurement reference level	1.5	V	
Logic output timing measurement reference level	1.5	V	
Logic input pulse levels	0 or 3.0	V	
Input rise/fall time	2	ns	
Output load for low and high impedance parameters	See Figure 4.1		
Output load for all other timing parameters	See Figure 4.2		

Figure 4.1 Output Load for Impedance Parameter Measurements

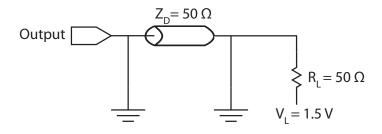
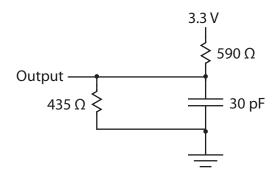


Figure 4.2 Output Load for all Other Parameter Measurements



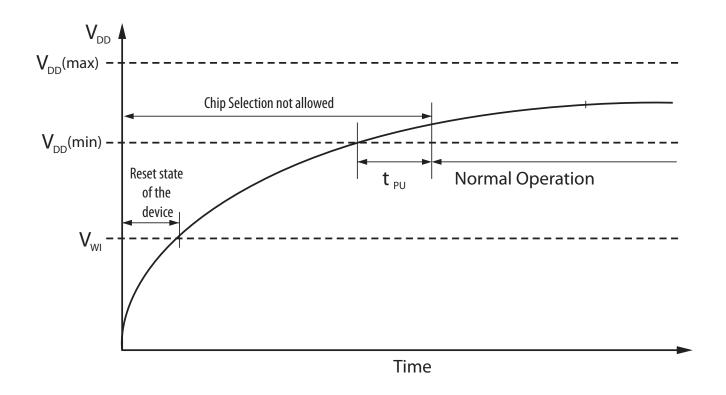
Power-Up Timing

The MR25H40 is not accessible for a start-up time, $t_{PU} = \underline{400} \, \mu s$ after power up. Users must wait this time from the time when V_{DD} (min) is reached until the first \overline{CS} low to allow internal voltage references to become stable. The \overline{CS} signal should be pulled up to V_{DD} so that the signal tracks the power supply during power-up sequence.

Table 4.3 Power-Up

Parameter	Symbol	Min	Typical	Max	Unit
Write Inhibit Voltage	V _{wi}	2.2	-	TBD	V
Startup Time	t _{PU}	400	-	-	μs

Figure 4.3 Power-Up Timing



MR25H40

Synchronous Data Timing Table 4.4 AC Timing Parameters¹

Parameter	Symbol	Min	Typical	Max	Unit
SCK Clock Frequency	f _{sck}	0	-	40	MHz
Input Rise Time	t _{RI}	-	-	50	ns
Input Fall Time	t _{RF}	-	-	50	ns
SCK High Time	t _{wh}	11	-	-	ns
SCK Low Time	t _{wL}	11	-	-	ns
Synchronous Data Timing (See figur	~e 4.4)				
CS High Time	t _{cs}	40	-	-	ns
CS Setup Time	t _{css}	10	-	-	ns
CS Hold Time	t _{CSH}	10	-	-	ns
Data In Setup Time	t _{su}	5	-	-	ns
Data In Hold Time	t _H	5	-	-	ns
Output Valid (Industrial)	t _v	0	-	9	ns
Output Valid (AEC-Q100 Grade 1)	t _v	0		10	ns
Output Hold Time	t _{HO}	0	-	-	ns
HOLD Timing (See figure 4.5)	'				
HOLD Setup Time	t _{HD}	10	-	-	ns
HOLD Hold Time	t _{CD}	10	-	-	ns
HOLD to Output Low Impedance	t _{LZ}	-	-	20	ns
HOLD to Output High Impedance	t _{HZ}	-	-	20	ns
Other Timing Specifications					
WP Setup To CS Low	t _{wps}	5	-	-	ns
WP Hold From CS High	t _{wph}	5	-	-	ns
Sleep Mode Entry Time	t _{DP}	3	-	-	μs
Sleep Mode Exit Time	t _{RDP}	400	-	-	μs
Output Disable Time	t _{DIS}	12	-	-	ns

 $^{^{\}mbox{\tiny 1}}\mbox{Operating Temperature Range, V}_{\mbox{\tiny DD}} \! = \! 3.0$ to 3.6 V, C $_{\!L} \! = \! 30$ pF

High Impedance

SO

Figure 4.4 Synchronous Data Timing

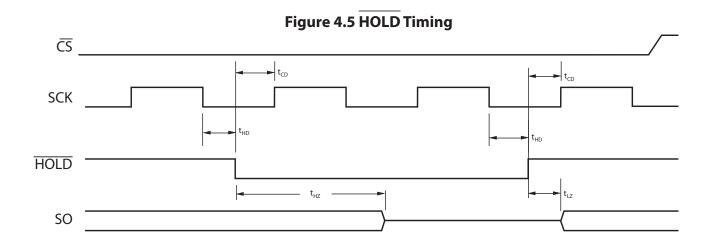


Figure 5.1 Part Numbering System

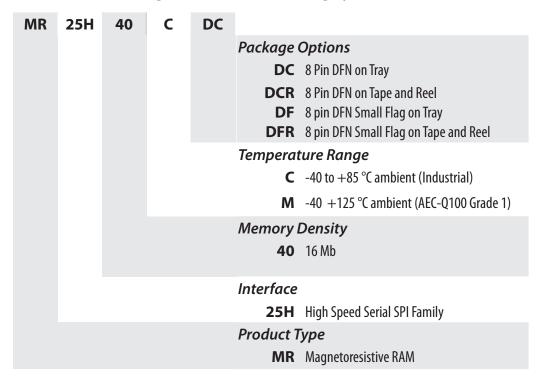


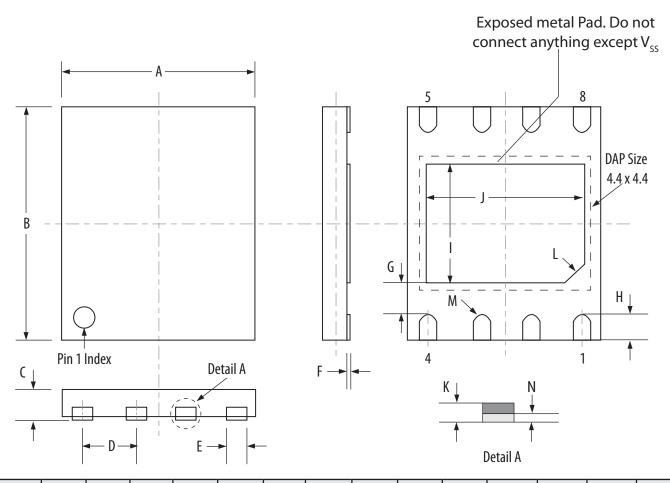
Table 5.1 Available Parts

Part Number	Description	Temperature
MR25H40CDC	3 V 4 Mb Serial MRAM 8-DFN Industrial	-40 to +85 C
MR25H40CDCR	3 V 4 Mb Serial MRAM 8-DFN Industrial T&R	-40 to +85 C
MR25H40MDC ¹	3 V 4 Mb Serial MRAM 8-DFN AEC-Q100 Grade 1	-40 to +125 C
MR25H40MDCR ¹	3 V 4 Mb Serial MRAM 8-DFN AEC-Q100 Grade 1 T&R	-40 to +125 C
MR25H40CDF	3 V 4 Mb Serial MRAM 8-DFN Small Flag Industrial	-40 to +85 C
MR25H40CDFR	3 V 4 Mb Serial MRAM 8-DFN Small Flag Industrial T&R	-40 to +85 C
MR25H40MDF ¹	3 V 4 Mb Serial MRAM 8-DFN Small Flag AEC-Q100 Grade 1	-40 to +125 C
MR25H40MDFR ¹	3 V 4 Mb Serial MRAM 8-DFN Small Flag AEC-Q100 Grade 1 T&R	-40 to +125 C

¹ Preliminary Products: These products are classified as Preliminary until the completion of all qualification tests. The specifications in this data sheet are intended to be final but are subject to change. Please check the Everspin web site www. everspin.com for the latest information on product status.

6. MECHANICAL DRAWINGS

Figure 6.1 DFN Package



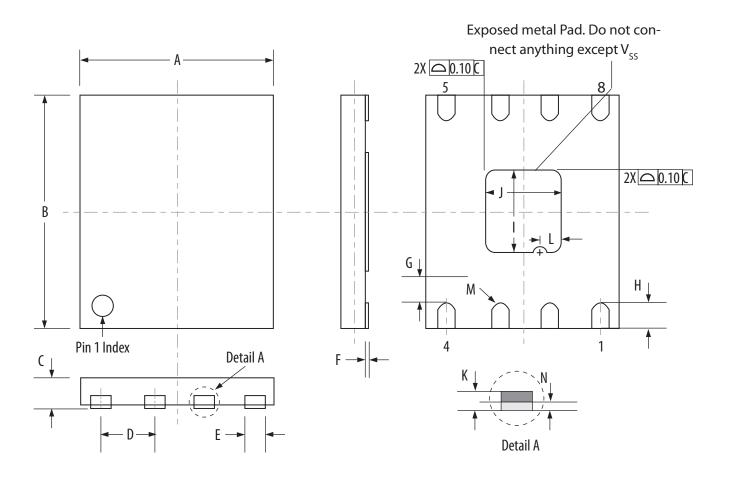
Dimension	Α	В	С	D	E	F	G	Н	ı	J	K	L	М	N
Max.	5.10	6.10	1.00	1.27	0.45	0.05	0.35	0.70	4.20	4.20	0.261	C0.35	R0.20	0.05
Min.	4.90	5.90	0.90	BSC	0.35	0.00	Ref.	0.50	4.00	4.00	0.195	00.00		0.00

NOTE:

- 1. All dimensions are in mm. Angles in degrees.
- 2. Coplanarity applies to the exposed pad as well as the terminals. Coplanarity shall be within 0.08 mm.
- 3. Warpage shall not exceed 0.10 mm.
- 4. Refer to JEDEC MO-229

6. MECHANICAL DRAWINGS

Figure 6.2 DFN Small Flag Package



Dimension	Α	В	С	D	E	F	G	Н	_	J	K		М	N
Max Min	5.10 4.90	6.10 5.90	0.90 0.80	1.27 BSC	0.45 0.35	0.05 0.00	1.60 1.20	0.70 0.50	2.10 1.90	2.10 1.90	.210 .196	C0.45	R0.20	0.05 0.00

NOTE:

- 1. All dimensions are in mm. Angles in degrees.
- 2. Coplanarity applies to the exposed pad as well as the terminals. Coplanarity shall be within 0.08 mm.
- 3. Warpage shall not exceed 0.10 mm.
- 4. Refer to JEDEC MO-229

7. REVISION HISTORY

Revision	Date	Description of Change
0	Jan 15, 2010	Product Concept Release
0.1	Feb. 23, 2010	Fixed typos in text.
1	May 5, 2010	Removed commercial specifications. All parts meet industrial specifications.
2	Jan 11, 2011	Preliminary Product Release. Updated description of status register non-volatility, WAKE command, Table 3.4.
3	Apr 25, 2011	Removed DIP package part to seperate datasheet. Added inset detail for mechanical package drawings.
4	September 22, 2011	Added AEC-Q100 Grade 1 ordering option. Revised Table 3.1, Table 3.2, Table 3.4, Table 4.4 revised and Note 2 deleted, revised Figure 5.1 and Table 5.1.
5	Nov 18, 2011	Corrected V_{OL} in Table 3.3 to read V_{OL} Max = V_{SS} + 0.2v. Corrected SI waveform in Figure 2.8. New Small Flag DFN package option added to Page 1 Features and available parts Table 5.1. DFN Small Flag drawing and dimensions table added as Figure 6.2. Figure 6.1, DFN Package, cleaned up with better quality drawing and dimension table. No specifications were changed in Figure 6.1.

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